


<b>Search Notes</b>  	<b>Application/Control No.</b>  10585870	<b>Applicant(s)/Patent Under Reexamination</b>  NAKAYAMA ET AL.
	<b>Examiner</b>  CHRISTOPHER E VERAA	<b>Art Unit</b>  3611

SEARCHED			
Class	Subclass	Date	Examiner
40	543, 612,	12/16/09	CeV
359	361	12/16/09	CeV

SEARCH NOTES		
Search Notes	Date	Examiner
history attached	12/16/09	CeV

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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